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Radiation environments and their main effects on electronic devices

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Outline

- Particles in Space and in atmosphere
- Useful definitions
- Introduction to particle-matter interaction
- Conclusions

Solar Wind



1980 February 16 - white light

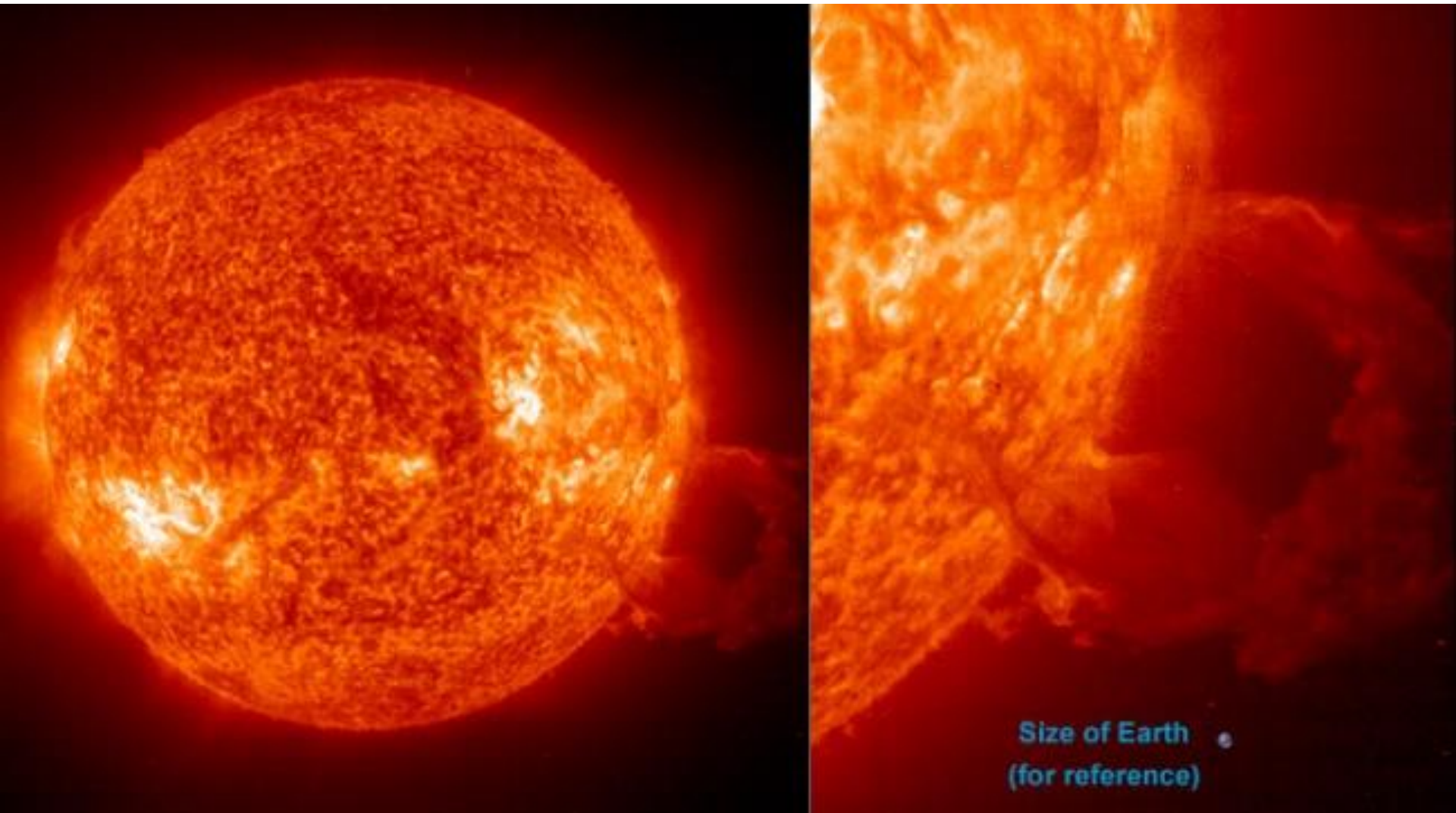


High Altitude Observatory/NCAR

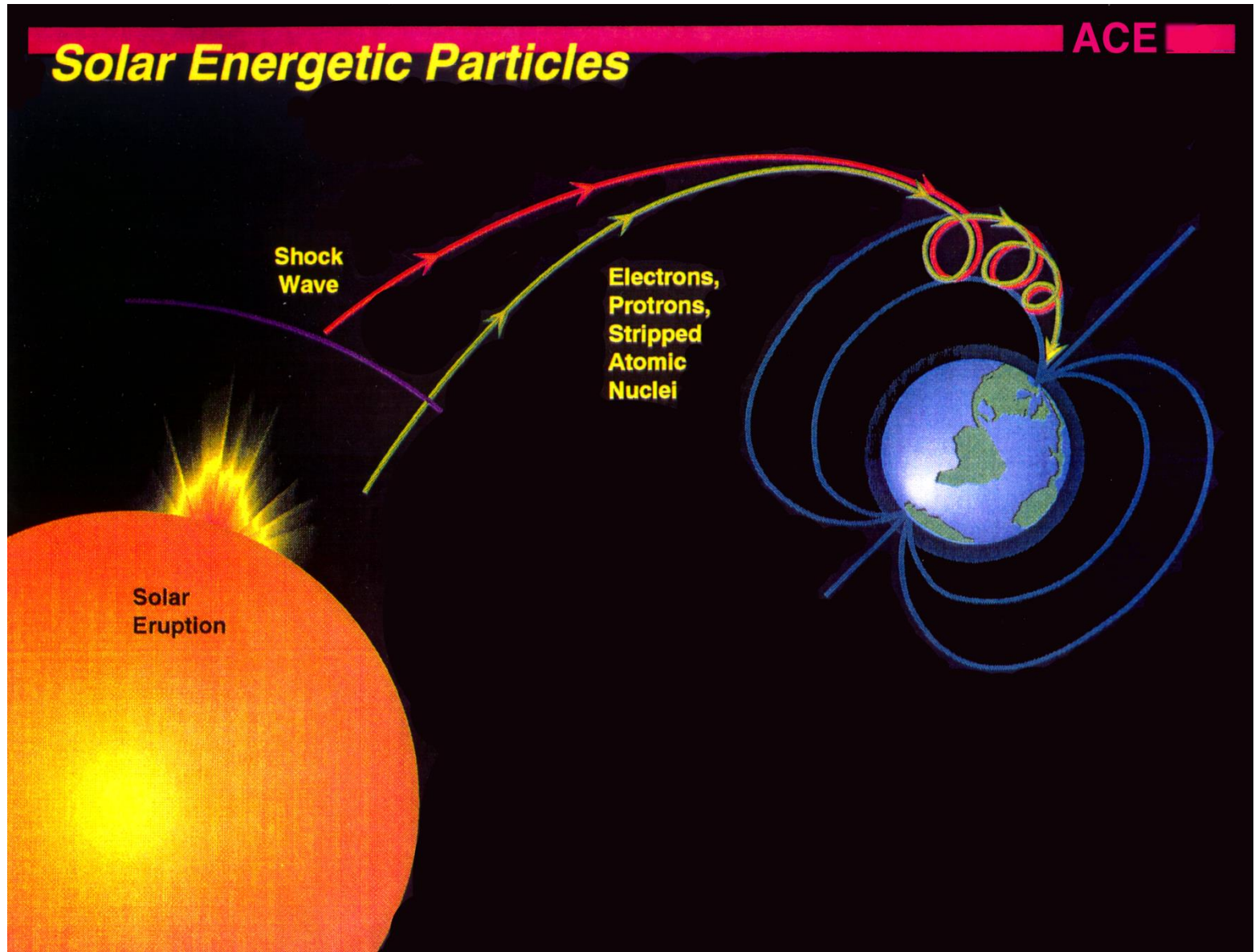
Solar flare



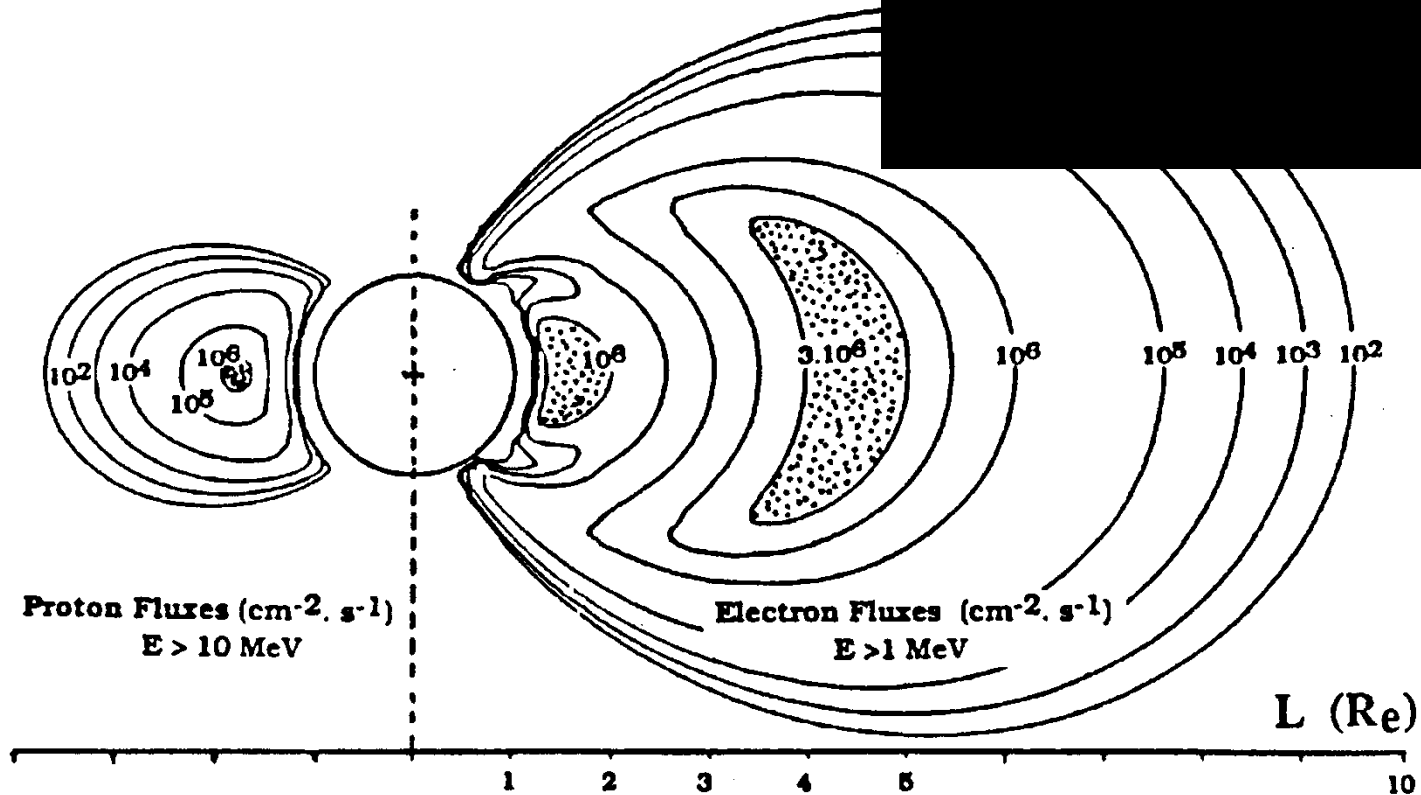
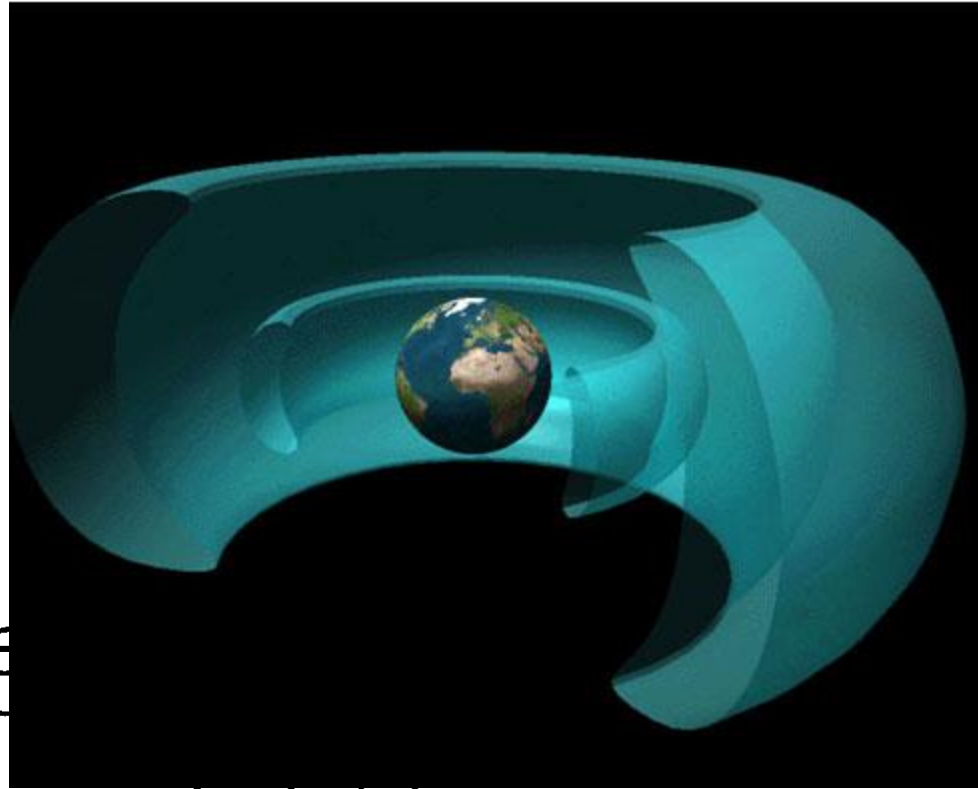
Solar Flare



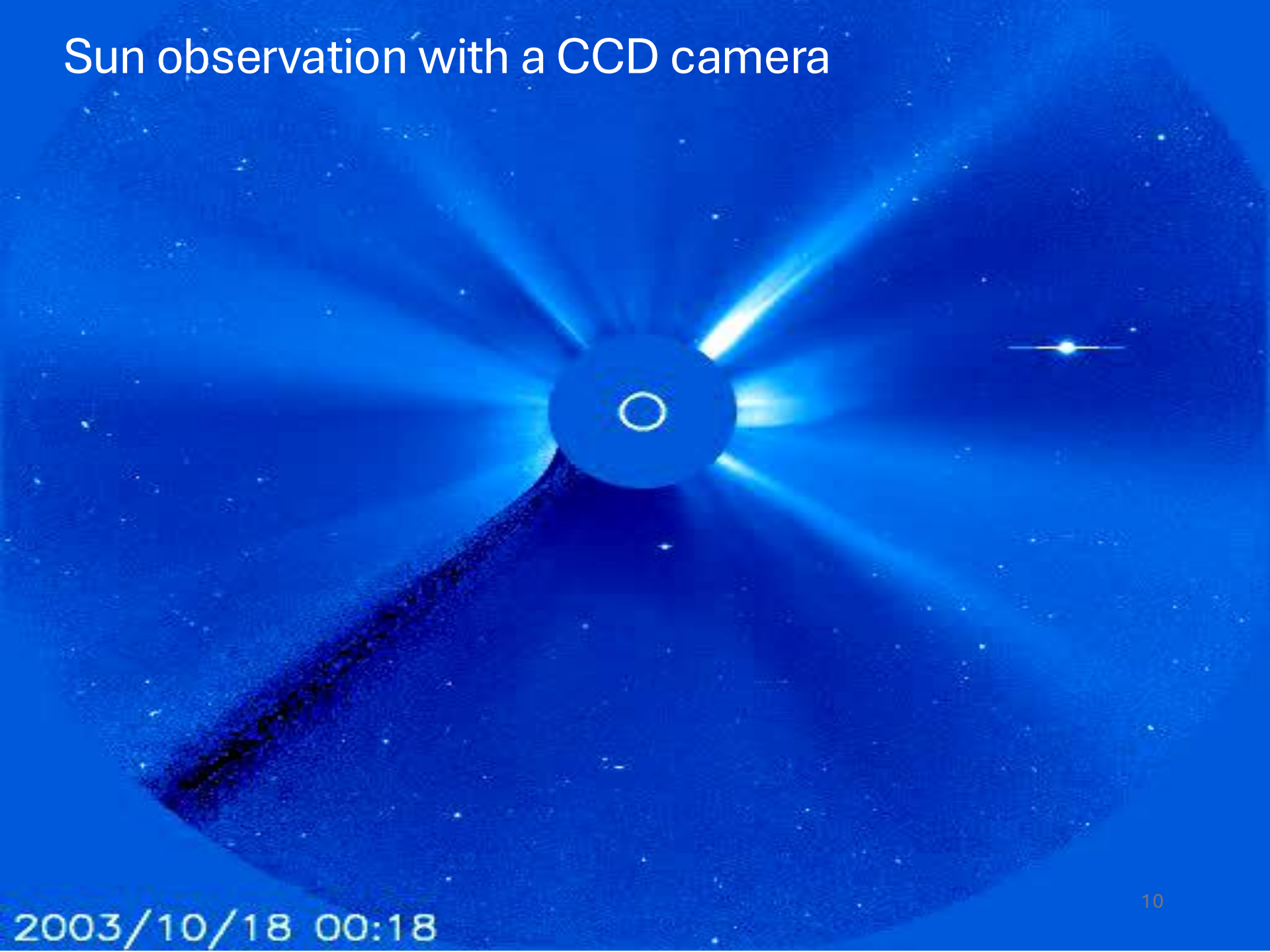
Radiation Belts



Radiation Belts

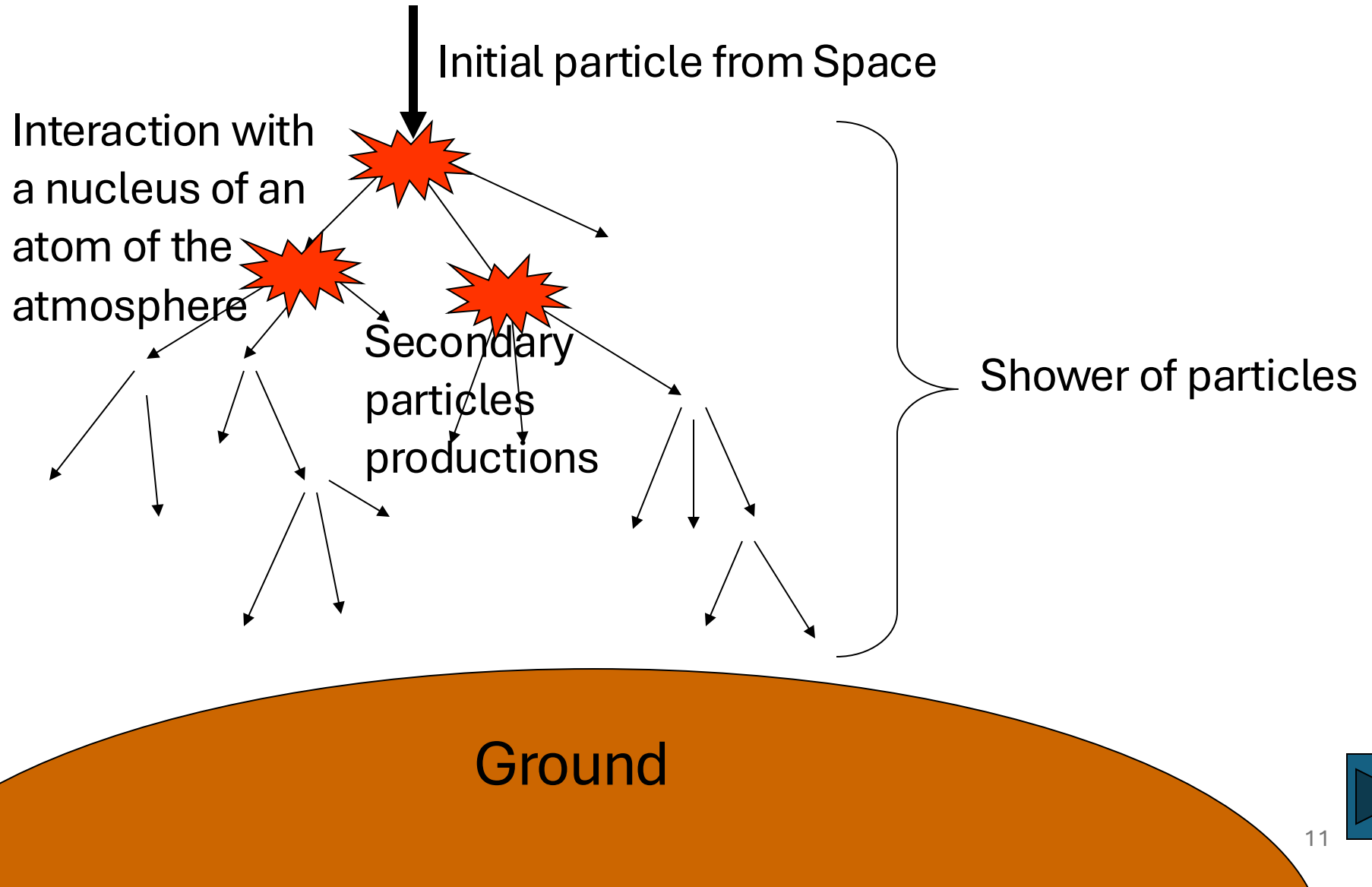


Sun observation with a CCD camera

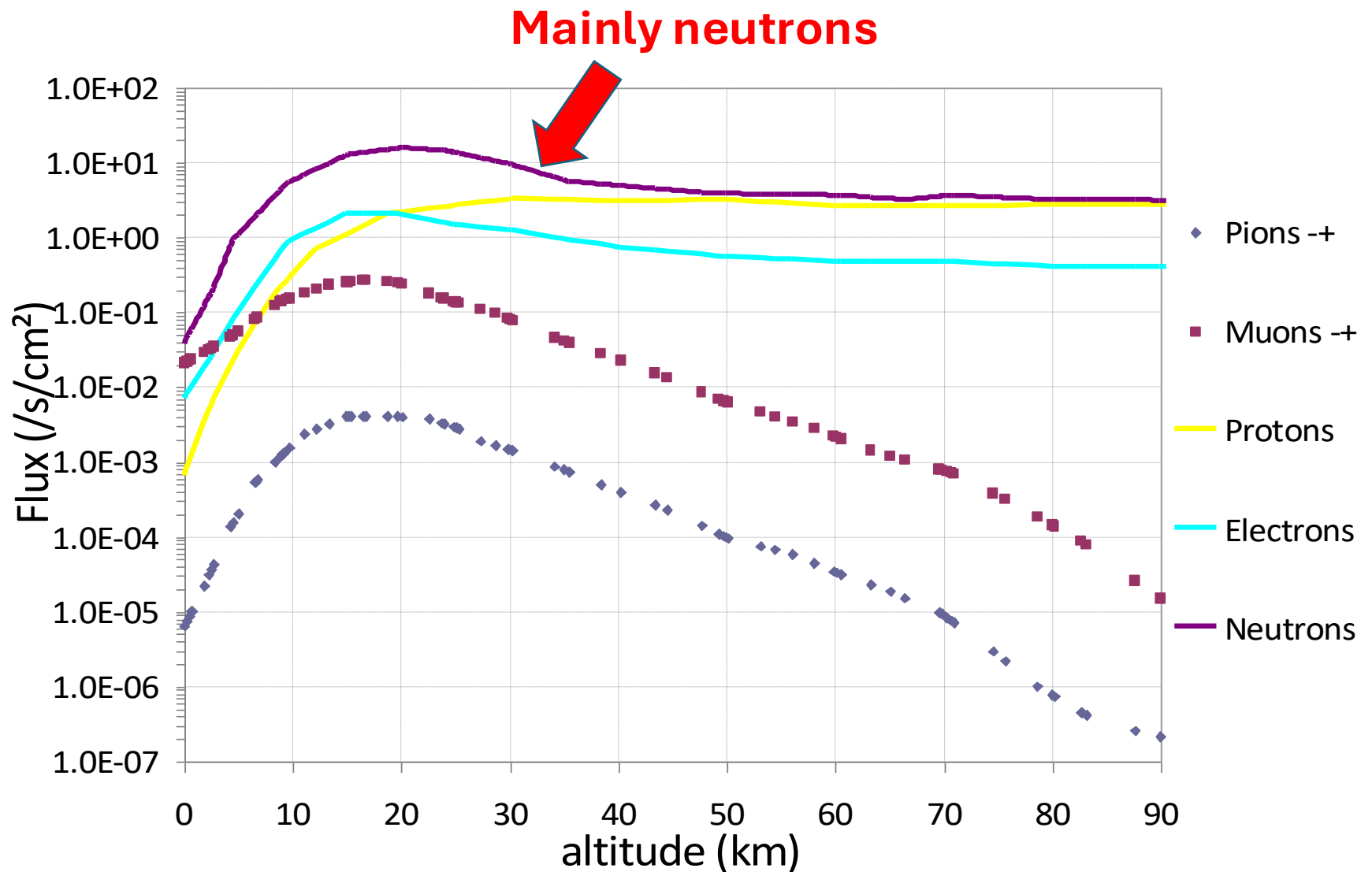


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In the Atmosphere



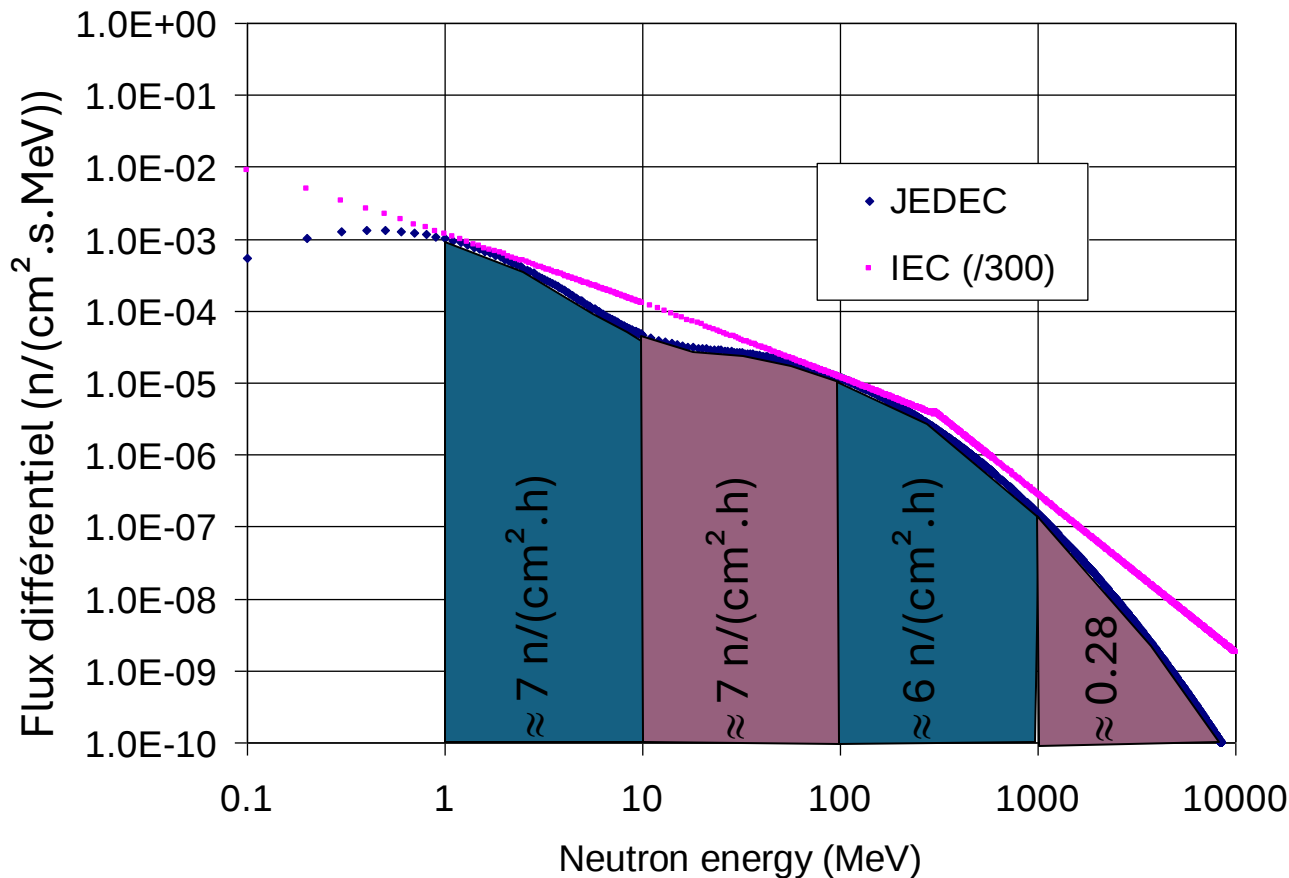
Particle flux in atmosphere



Differential neutron flux in atmosphere

Allows knowing the energy distribution of particles.

Area under the curve represents the particle flux



Around $20 \text{ n}/(\text{cm}^2 \cdot \text{h})$ with energy greater than 1 MeV (after JEDEC).

NB: it actually depends on geolocation and solar activity

Outline

- Particles in Space and in atmosphere
- **Useful definitions**
- Introduction to particle-matter interaction
- Conclusions



Useful quantities

Energy unit

Flux (fluence rate)

Fuence

Cross section

Soft Error Rate (SER)

Probability of interaction

Mean free path

Stopping Power

Range of a particle

LET-NIEL

Dose

Dose Rate



Energy unit

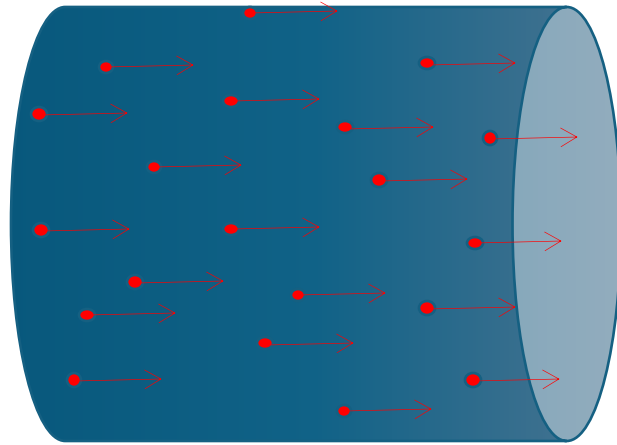
Two useful units :

- Joule (J)
- electron Volt : **$1 \text{ eV} = 1.6 \times 10^{-19} \text{ J}$**

In silicon, the required energy to produce one electron-hole pair is 3.6 eV.

Therefore, in silicon an energy of 3.6 eV maybe associated to a charge of $\pm 1.6 \times 10^{-19} \text{ C}$

Flux – Fluence Rate



n = density of particles
 v = velocity of particles

The Fluence rate $\frac{dF}{dt}$ is defined by:

$$\frac{dF}{dt} = n' v$$

$\uparrow$ $\uparrow$
/cm³ cm/s

Fluence rate is often called flux density or flux.
It is expressed in **cm⁻².s⁻¹**

Fluence

Fluence is the integration of Fluence Rate over time:

$$F = \int_0^{t_{irr}} \frac{dF}{dt} dt = \int_0^{t_{irr}} \phi' v dt$$

If the fluence rate is constant (which is often the case):

$$F = \frac{dF}{dt} \cdot t_{irr}$$

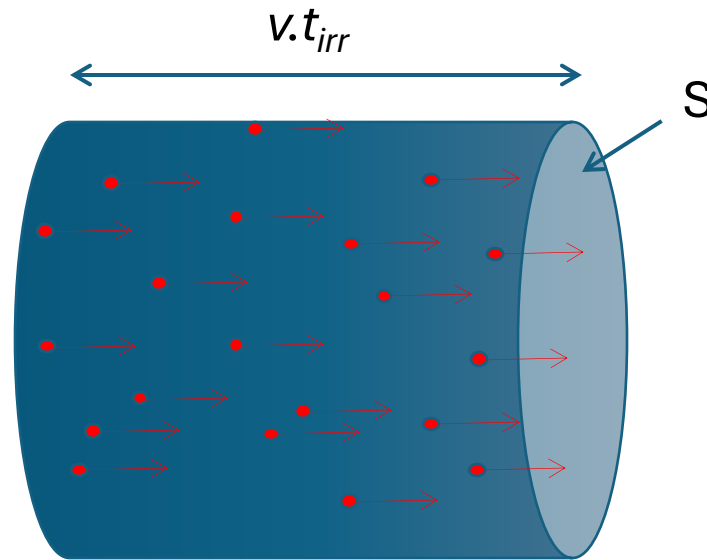
 /cm²  Irradiation time



Fluence - Fluence Rate: link with the number of emitted particles

Let us assume that N is the number of particles emitted with a velocity v and during a time t_{irr} .

At the end of irradiation, all the particles belong to a cylinder of area S and length $v \cdot t_{irr}$



The density is thus:

$$n = \frac{N}{S' v' t_{irr}}$$

The fluence rate is:

$$\frac{dF}{dt} = n' v = \frac{N}{S' t_{irr}}$$

and the rate is:

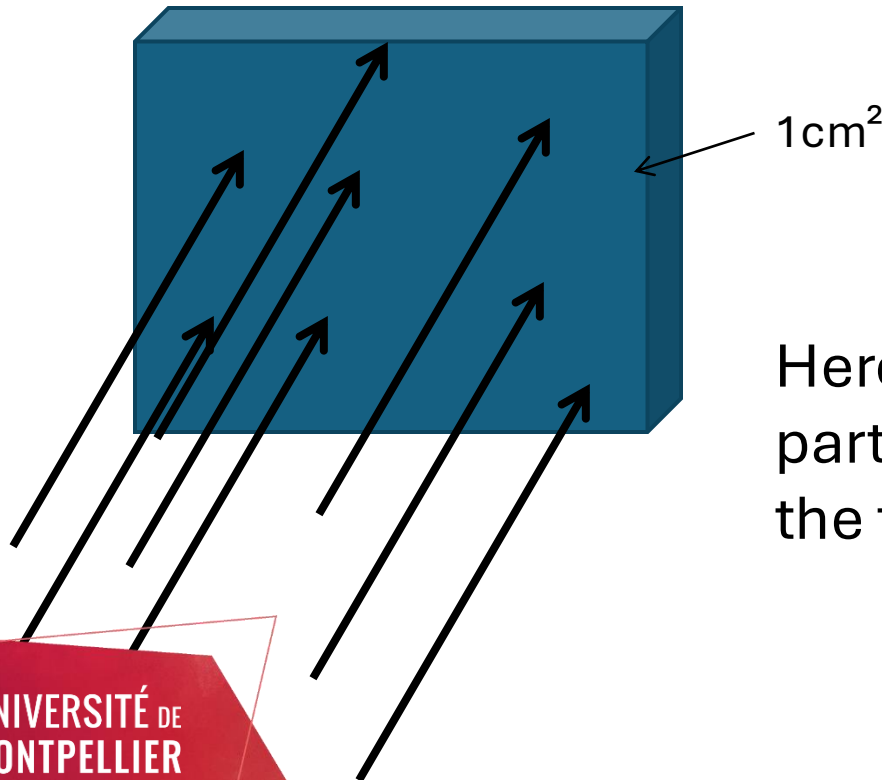
$$F = \frac{dF}{dt} t_{irr} = \frac{N}{S}$$

Finally, the fluence can be seen as the number of particle per area un

Fluence: example

The fluence can be seen as the number of particles per unit of area

Unit : **part/cm²**



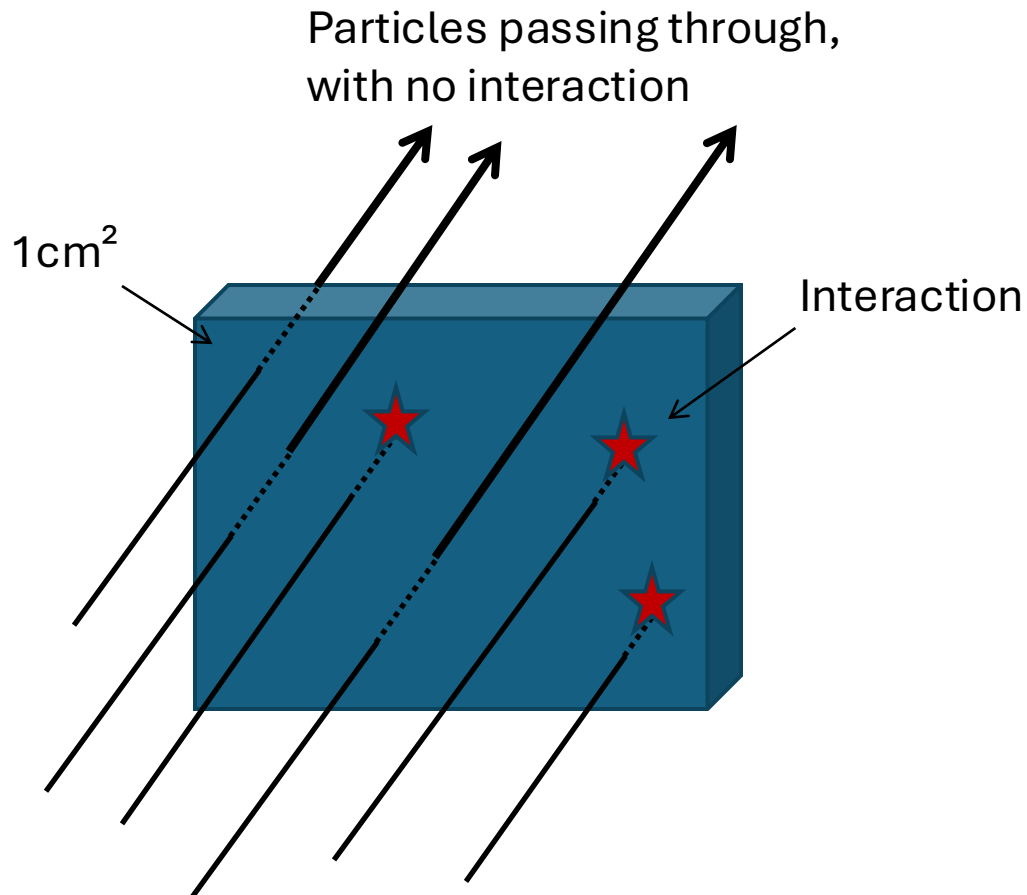
Here, each arrow being a particle,
the fluence is 8 part/cm²



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Cross section

The concept of **cross section** is used to express the probability of a process (e.g. particle interaction).



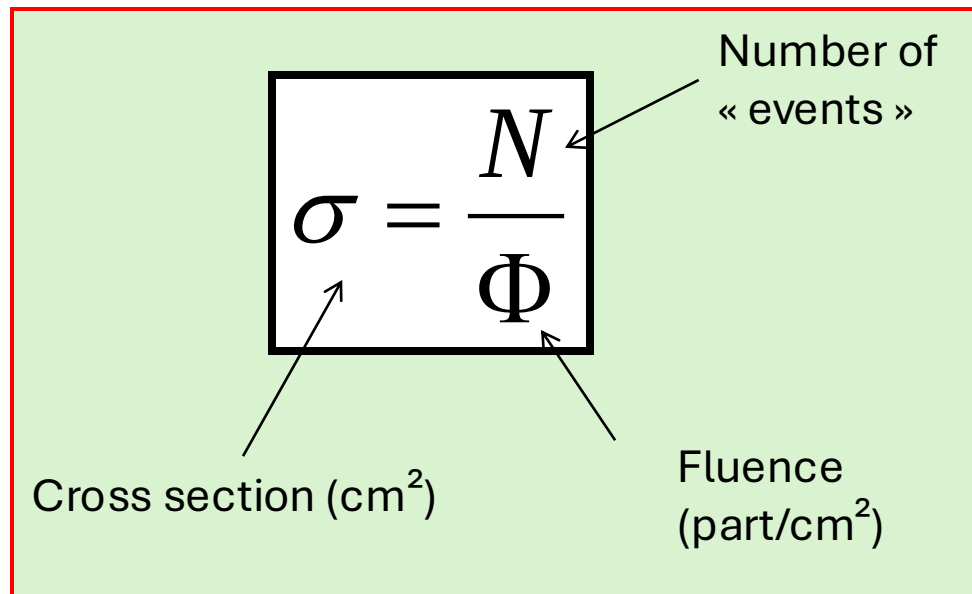
6 incident particles
1 cm² sample
Fluence = 6 part/cm²

6 incident particles
3 interactions
1 cm² sample
We can consider that only 3/6 of the
area sample is efficient :
Interaction cross section = 0.5 cm²

Cross section

The concept of **cross section** is used to express the probability of a process (e.g. particle interaction).

More generally the cross section is defined by:



The diagram shows the equation $\sigma = \frac{N}{\Phi}$ enclosed in a black rectangular box. This box is centered within a larger light green rectangular area. Three arrows point from text labels to the equation: one from the top right to the variable N , one from the bottom right to the variable Φ , and one from the bottom left to the variable σ .

Number of
« events »

Cross section (cm^2)

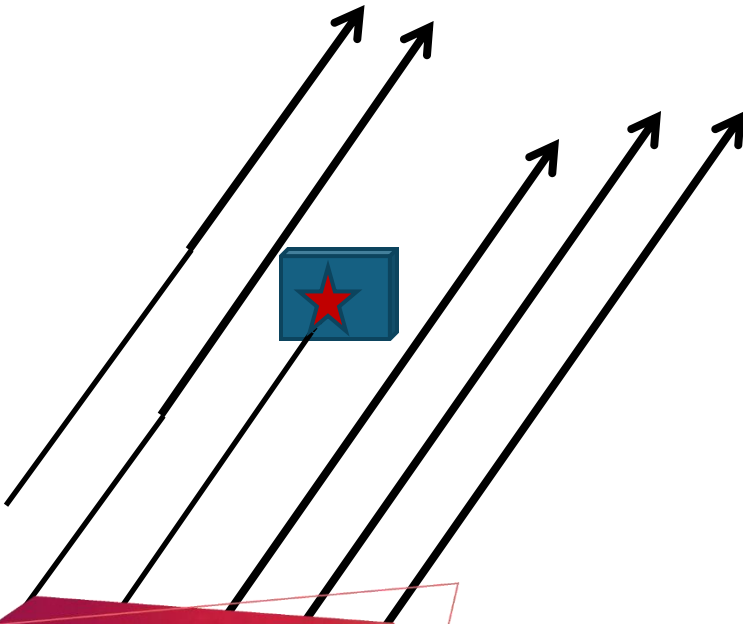
Fluence
(part/cm^2)

NB: the considered cross section is associated to a given process.
For example :

- particle that interacts
- particle that deposits more than a given energy

Cross section

If we reduce the size of the sample, the cross section obviously decreases



$$\sigma = \frac{N}{\Phi}$$

Number of « events »

Cross section (cm²)

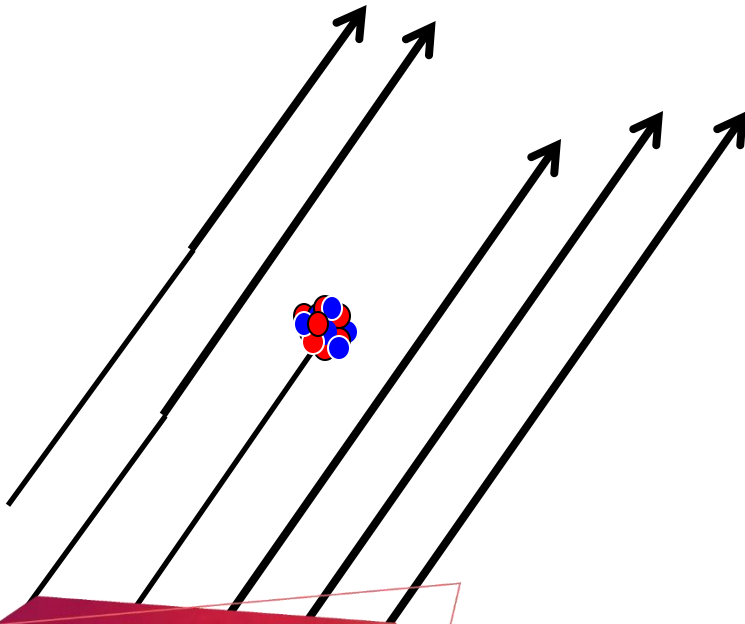
Fluence (part/cm²)

Cross section

If we reduce the size of the sample, the cross section obviously decreases.
If we reduce the size so that the sample is a unique atom (or nucleus) the obtained cross section is the “microscopic cross section” or “nuclear cross section”.

It expresses the probability of interaction between the incident particle and the target nucleus.

As the involved area is small, the unit of barn is useful : **1 barn = 10^{-24} cm^2**



$$\sigma = \frac{N}{\Phi}$$

Number of « events »

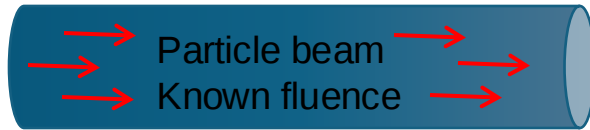
Cross section (cm^2)

Fluence (part/cm^2)



Cross section: practically

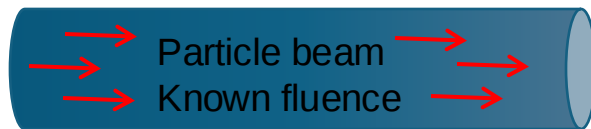
Nuclear cross section



$$\sigma = \frac{N}{\Phi}$$

N = Number of interactions

Failure cross section



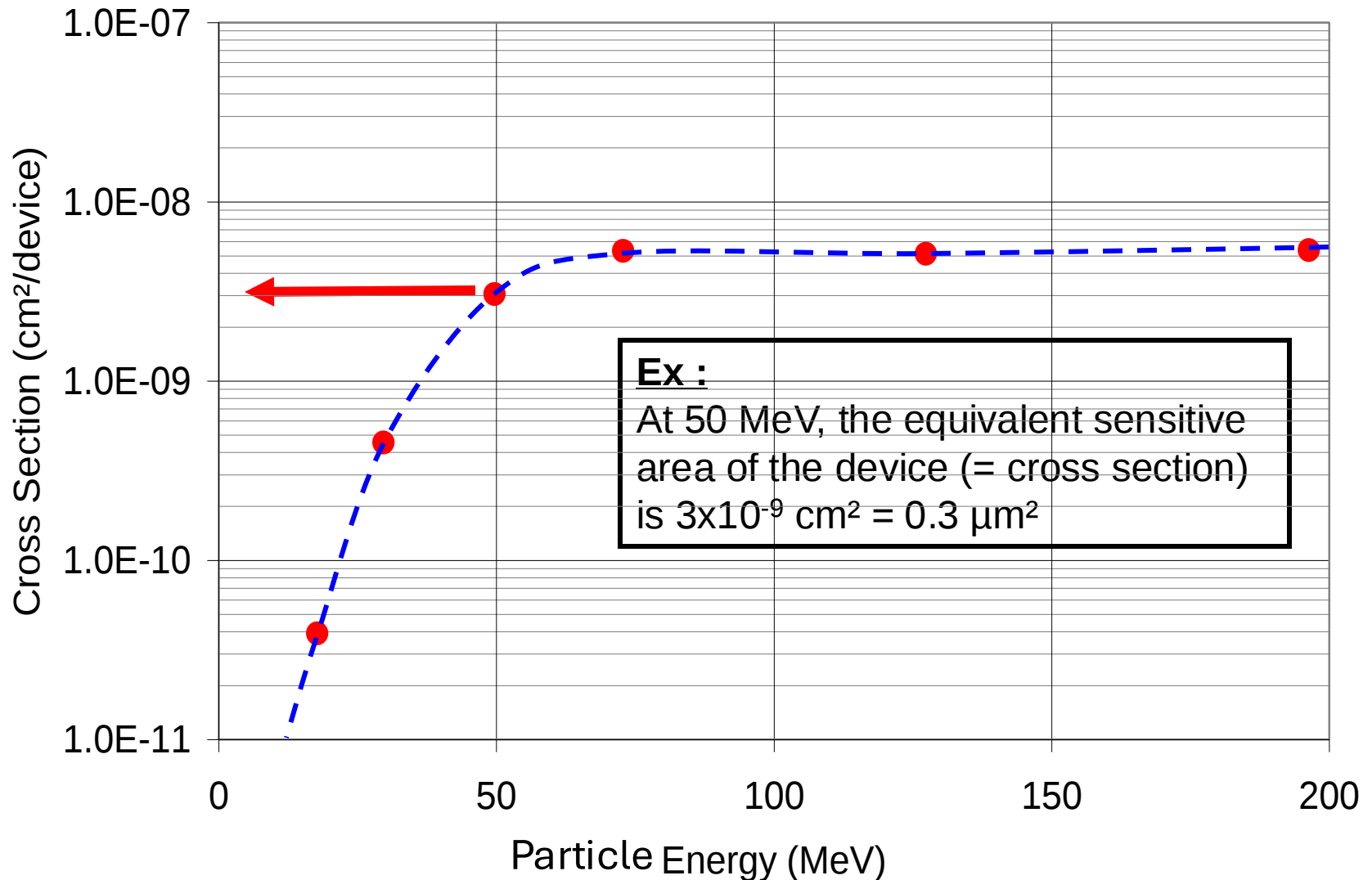
$$\sigma = \frac{N}{\Phi}$$

N = Number of failures



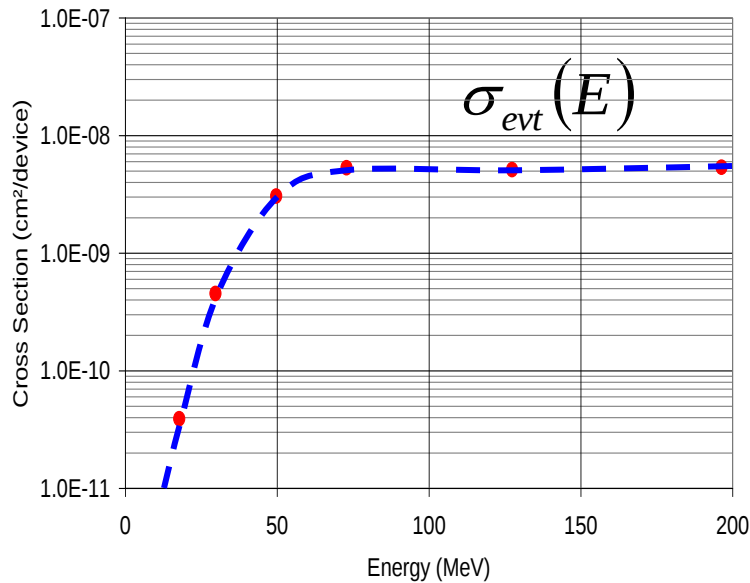
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Electronics under beam

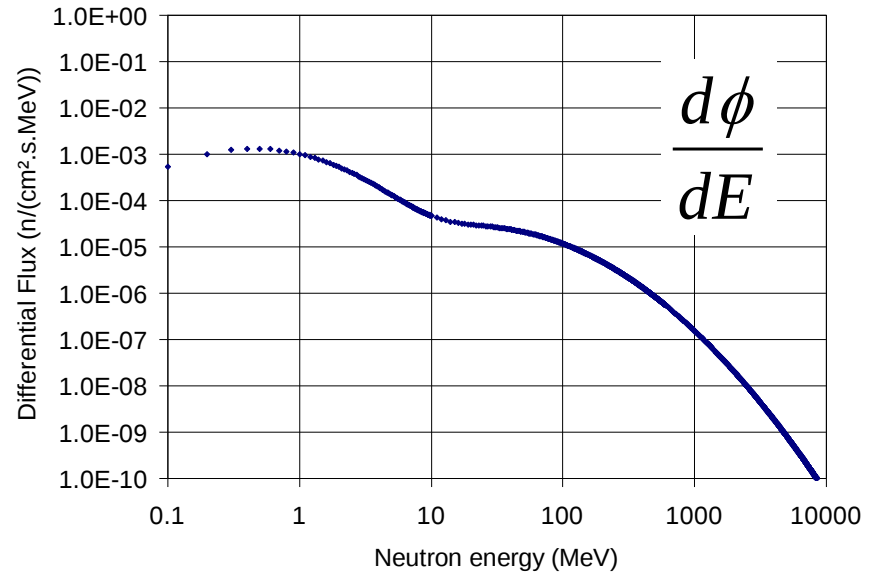


Soft Error Rate (SER)

Device



Environment



$$SER = \int \frac{dj}{dE} \times \sigma_{evt}(E) dE$$



Soft Error Rate (SER)

$$SER = \int \frac{dj}{dE} \times s_{evt}(E) dE$$

Unit : events per unit of time

- **Avionic applications (IEC) :**

Events per hour

- **Ground level applications (JEDEC) :**

Event/ 10^9 hours ($\approx$ events/100 000 years)

This is called FIT (Failure In Time)

1 FIT = 1 event / 1 billion of hours

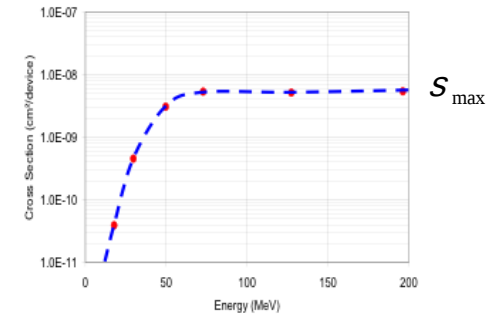


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Example of quick calculations

Device under beam

$$SER = \int \frac{dj}{dE} \times s_{evt}(E) dE$$



$$SER < \int \frac{dj}{dE} \times s_{\max} dE = s_{\max} \int \frac{dj}{dE} dE = s_{\max} \cdot j$$

$\nearrow$ $5 \times 10^{-14} \text{ cm}^2/\text{bit}$ $\nearrow$ $12\,000 \text{ n/cm}^2/\text{heure}$

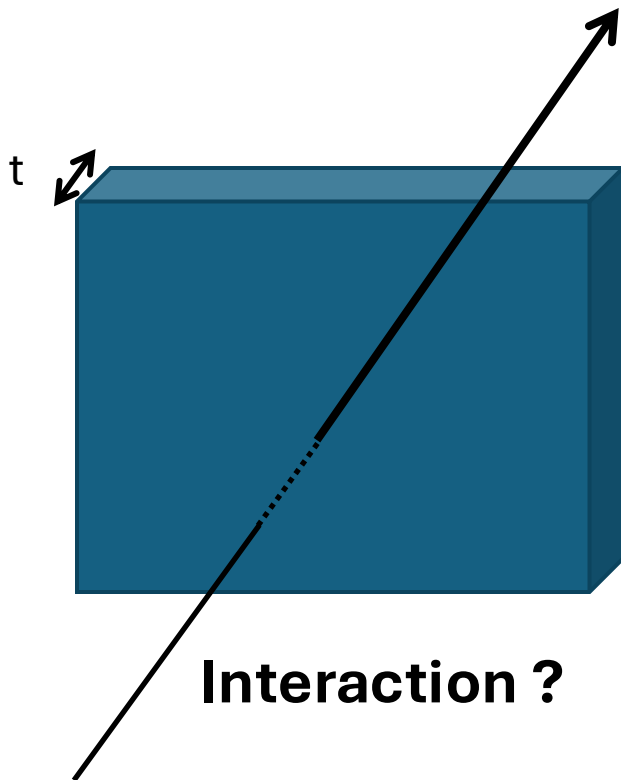
$$SER < 6 \times 10^{-10} \text{ SEU/bit/hour}$$

$$SER < 0.6 \text{ SEU/bit/billion of hours}$$

$$SER < 630\,000 \text{ FIT/MBit}$$

Probability of interaction

Knowing the interaction cross section σ , it is easily possible to calculate the probability for a **single** incident particle to interact in a foil of thickness t and with N_{at} atoms/cm³:



Probability of non-interaction

$$P_{trans} = e^{-N_{at} \sigma t}$$

Probability of interaction

$$P_{int} = 1 - e^{-N_{at} \sigma t}$$

Absorption coefficient

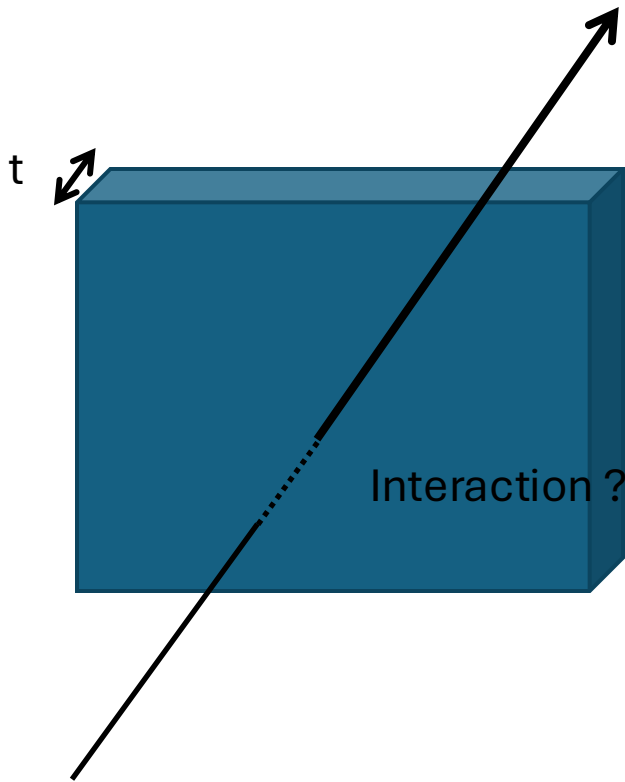
The probability of transmission for a particle is:

$$P_{trans} = 1 - P = e^{-N_{at} S t}$$

If N_0 is the number of incident particles, the number of transmitted particles is:

$$N_{trans} = N_0 e^{-N_{at} S t}$$

which is called the BEER law



$N_{at} S$ is called the absorption coefficient (unit: **cm⁻¹**)

Mean free path

We have seen that the probability of interaction is given by:

$$P_{\text{int}} = 1 - e^{-N_{\text{at}} s t}$$

The mean free path is defined by:

$$\lambda = \frac{1}{N_{\text{at}} s}$$

It expresses the typical range of particle before interacting

Unit : generally **cm**

If the particle travels a distance equal to λ it has a probability of interaction which is:

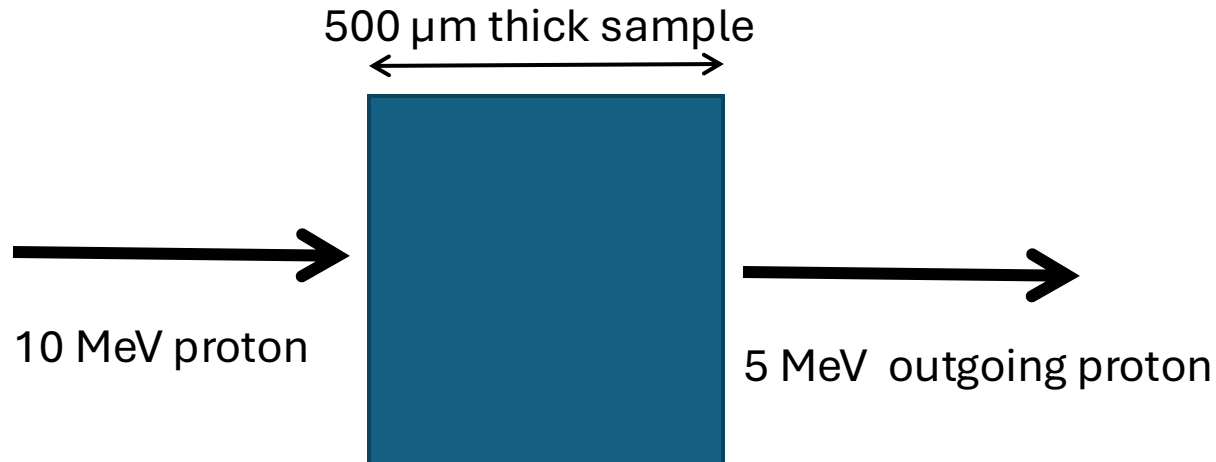
$$P(\lambda) = 1 - e^{-N_{\text{at}} s \lambda} = 1 - e^{-1} = 0.63$$

Stopping Power

The stopping power is defined as the energy loss of a particle per unit of length:

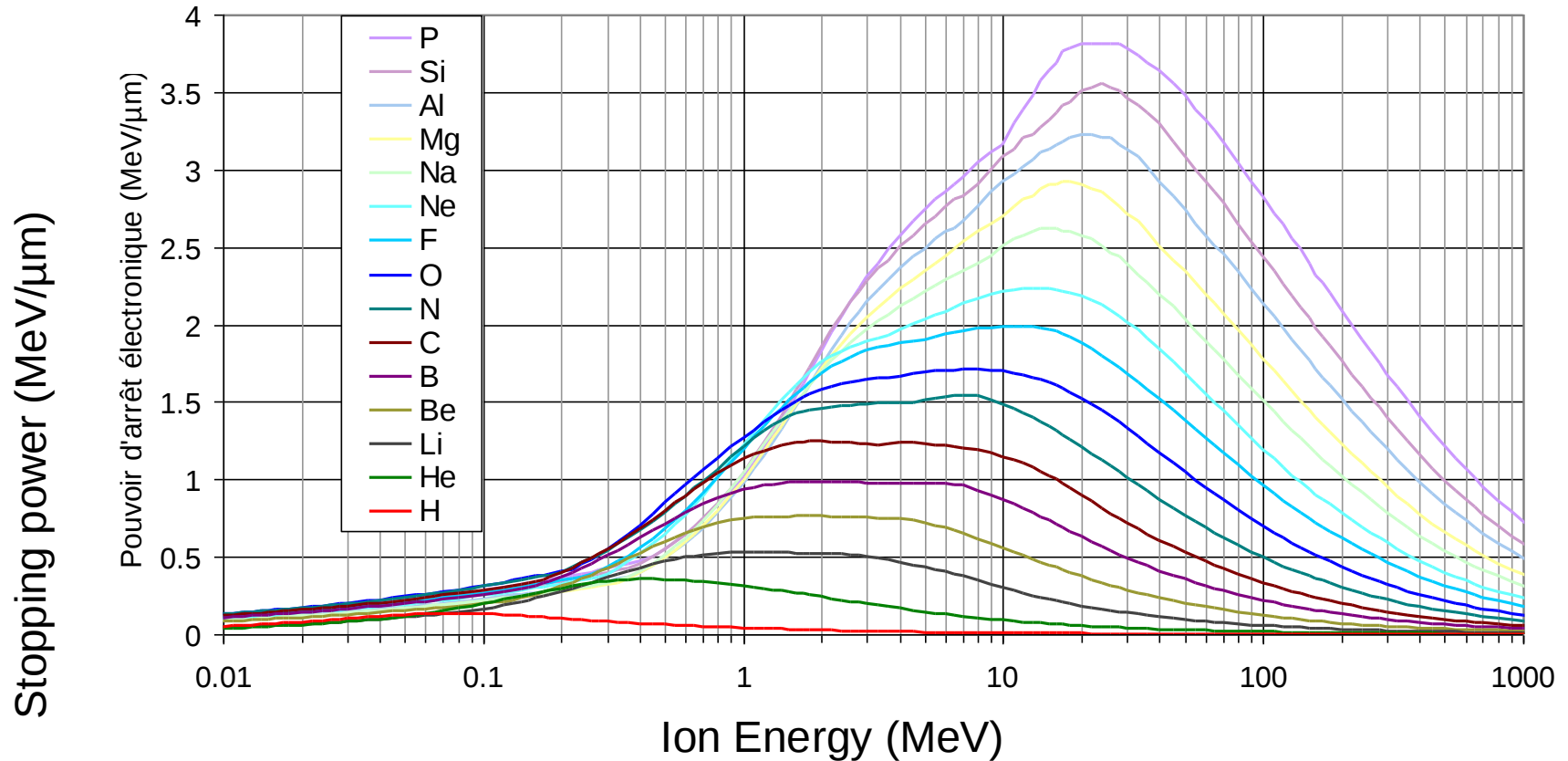
$$S = \text{Stopping power} = - \frac{dE}{dx} > 0$$

Natural unit: **MeV/cm** or **MeV/ μm**



$$\text{Mean stopping power} = \frac{-\Delta E}{t} = \frac{-(5 - 10)\text{MeV}}{500 \mu\text{m}} = 10\text{keV}/\mu\text{m}$$

Example: stopping power of ions in silicon



SRIM code by J. Ziegler



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Stopping power: unit

- Natural unit: **MeV/cm** or **MeV/μm**
- In order to have a stopping power which does not depend on the material state (gas, solid, liquid), it is useful to divide the « natural » stopping power by the volumic mass:

$$\textit{Stopping power} = - \frac{1}{r} \frac{dE}{dx} > 0$$

in mg/cm³ 

- Therefore, the stopping power is often expressed in **MeV.cm²/mg**
- NB: the volumic mass for silicon is ρ=2.32 g/cm³

Range of a particle

The range of a particle is simply the distance travelled by the particle before being stopped:

$$R = \int_0^R dx = \int_E^0 \frac{dx}{dE} dE = \int_E^0 \frac{1}{\frac{dE}{dx}} dE = \int_0^E \frac{1}{\frac{dE}{dx}} dE = \int_0^E \frac{1}{S} dE$$

$$R = \int_0^E \frac{1}{\text{Stopping power}} dE$$

in **cm** or **μm**

in MeV/cm or MeV/μm

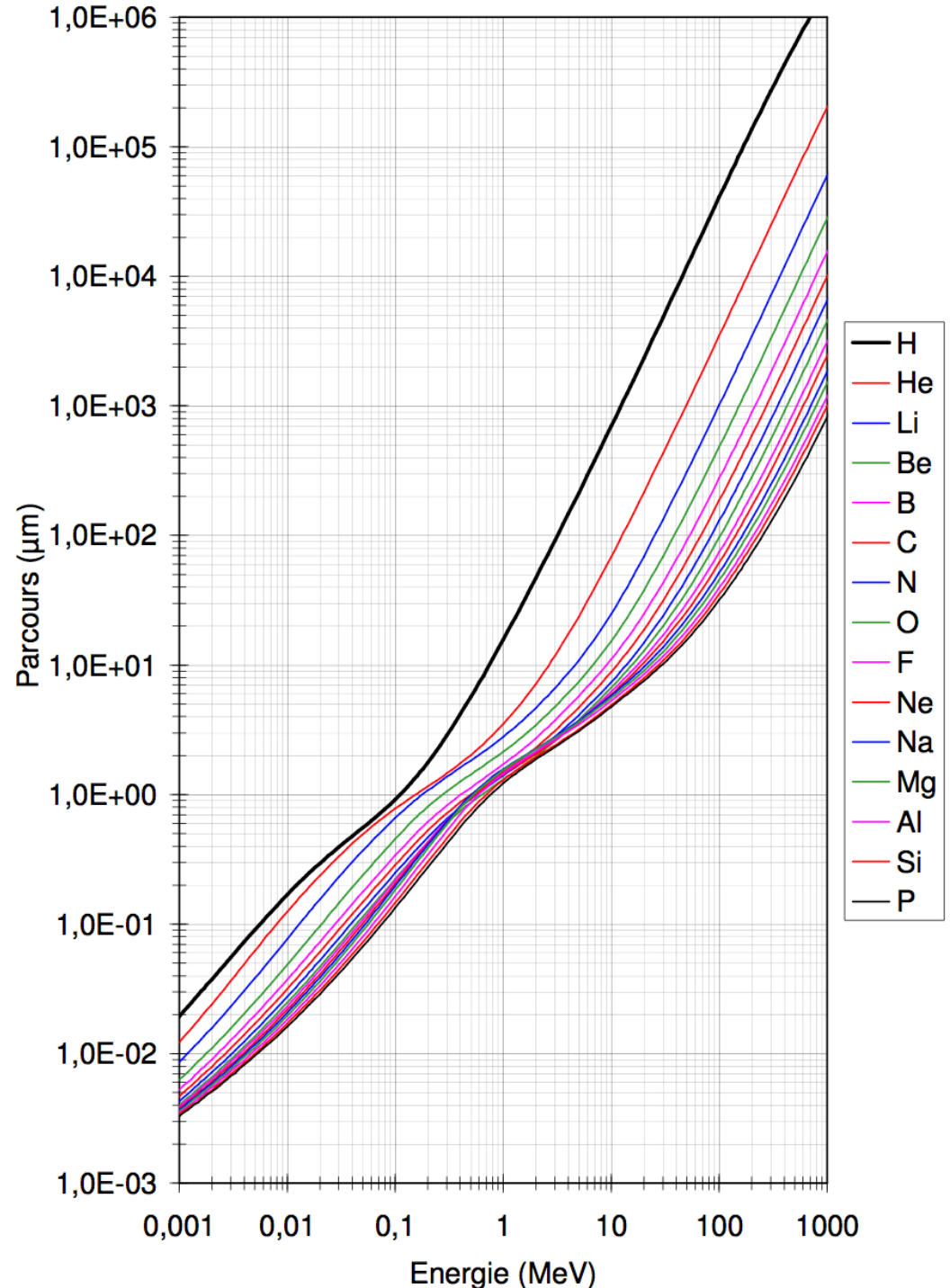


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Range of light ions in silicon

The range is the distance of a particle before being stopped.

Generally expressed in **cm** or **μm**



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LET-NIEL

Particles lose their energy by interacting either with electrons of atoms (ionization) or with nucleus of atom.

The stopping power can thus be written:

$$\textit{Stopping power} = \underbrace{\frac{dE}{dx} \bigg|_{\text{electron}} + \frac{dE}{dx} \bigg|_{\text{nuclear}}}_{\frac{dE}{dx} \bigg|_{\text{vibration}} + \frac{dE}{dx} \bigg|_{\text{displacement}}}$$



LET-NIEL

Particles lose their energy by interacting either with electrons of atoms (ionization) or with nucleus of atom.

The stopping power can thus be written:

$$\text{Stopping power} = -\frac{dE}{dx} \Big|_{\text{electron}} + -\frac{dE}{dx} \Big|_{\text{nuclear}}$$

**Called Linear Energy Transfer
or LET**

Unit: MeV.cm²/mg

$$-\frac{dE}{dx} \Big|_{\text{vibration}}$$

$$+\frac{dE}{dx} \Big|_{\text{displacement}}$$

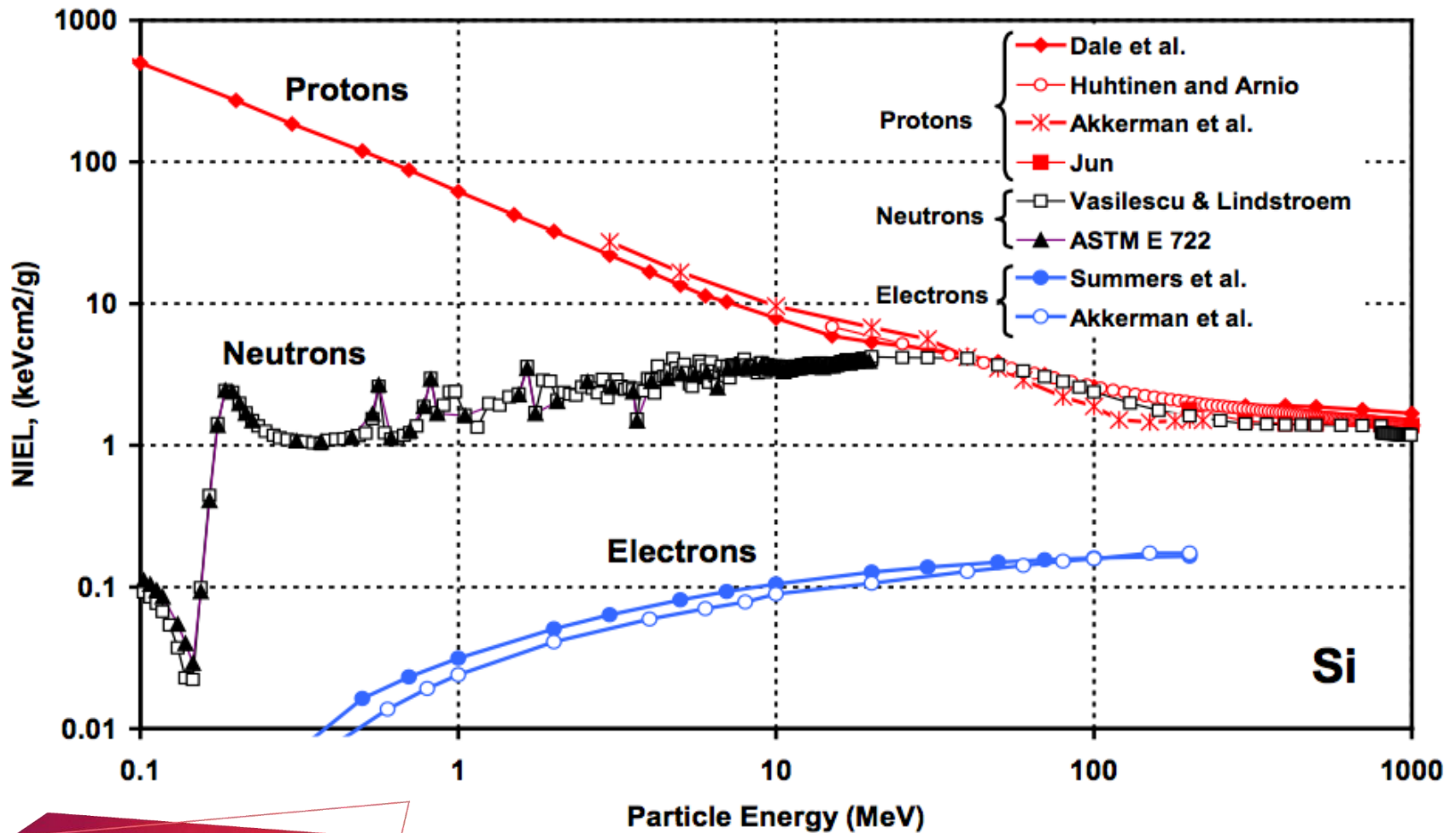
**Called Non Ionizing Energy Loss
or NIEL**

Unit: MeV.cm²/mg



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NIEL in Silicon



Dose

Absorbed dose is used for purposes of radiation protection and assessing dose or risk to humans and materials in general terms.

Absorbed dose is the amount of radiation absorbed in a material.

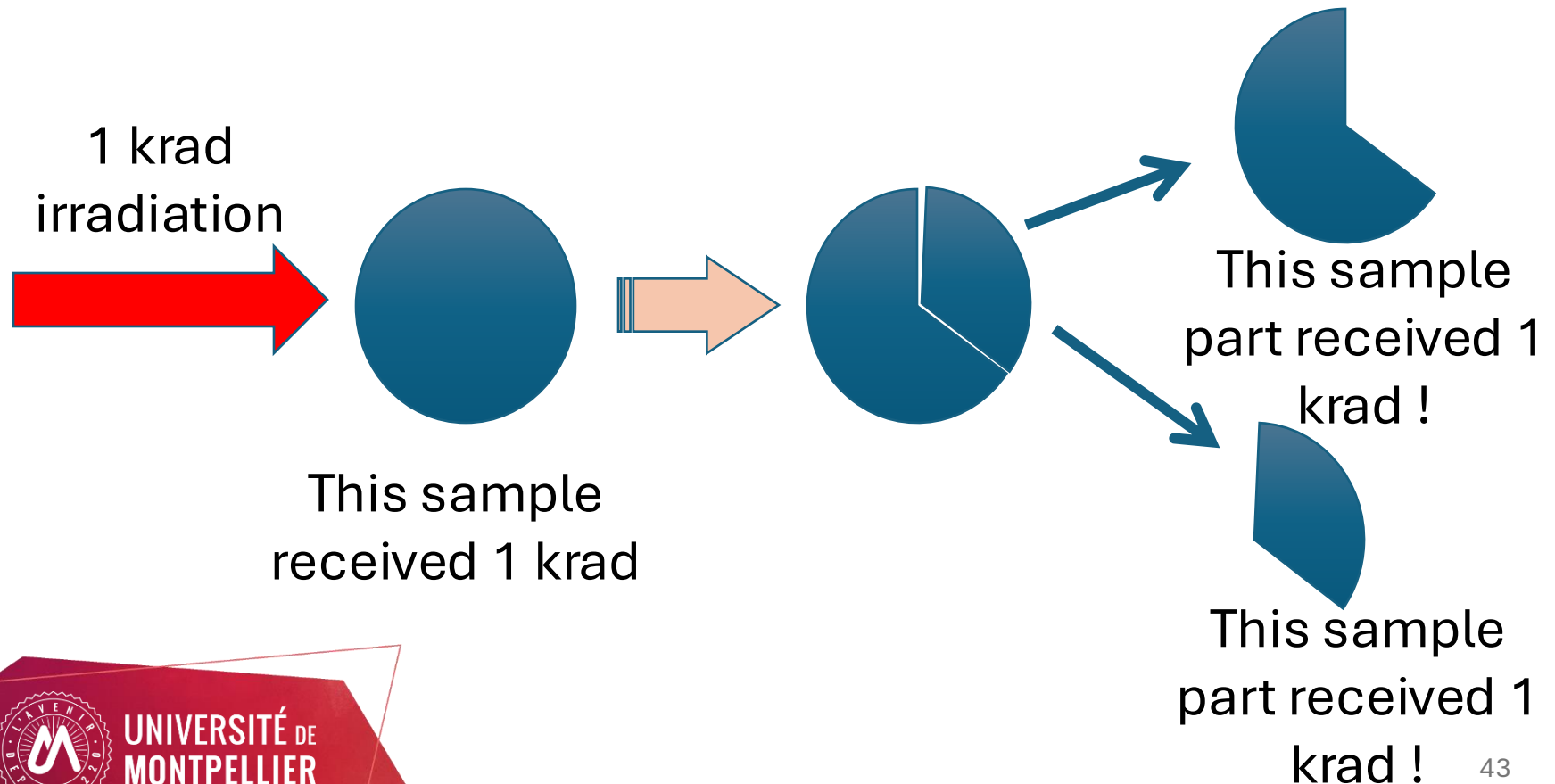
Absorbed dose is usually defined as energy deposited (joule) per unit of mass (kilogram).

Special unit: **1 Gy = 1 J/kg**

In the radiation effect community the unit of **rad** is used.
1 Gy = 100 rad

Dose

Dose is an intensive property (like temperature)



Dose Rate

- A dose of 1 krad has not the same effect on a device if it is deposited in a short time or a long time.
- The dose rate allows quantifying the rate at which the dose is deposited:

$$\dot{D} = \frac{dD}{dt}$$

- Expressed for example in **krad/h** or **rad/s**



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Forces at play

Force	Range of the force (m)	Relative Strength	At play in
Gravitational	∞	10^{-38}	Astrophysics
Weak	10^{-18}	10^{-5}	Nuclear decay
Electromagnetic	∞	$\alpha = 1/137$	Radiation matter interaction
Strong	10^{-15}	1	

Electromagnetic force

Strong force

uncharged particles

Charged particles

Light particles

Heavy particles

Nucleons

Photons

Electrons,
positrons

Ions

Protons

Neutrons

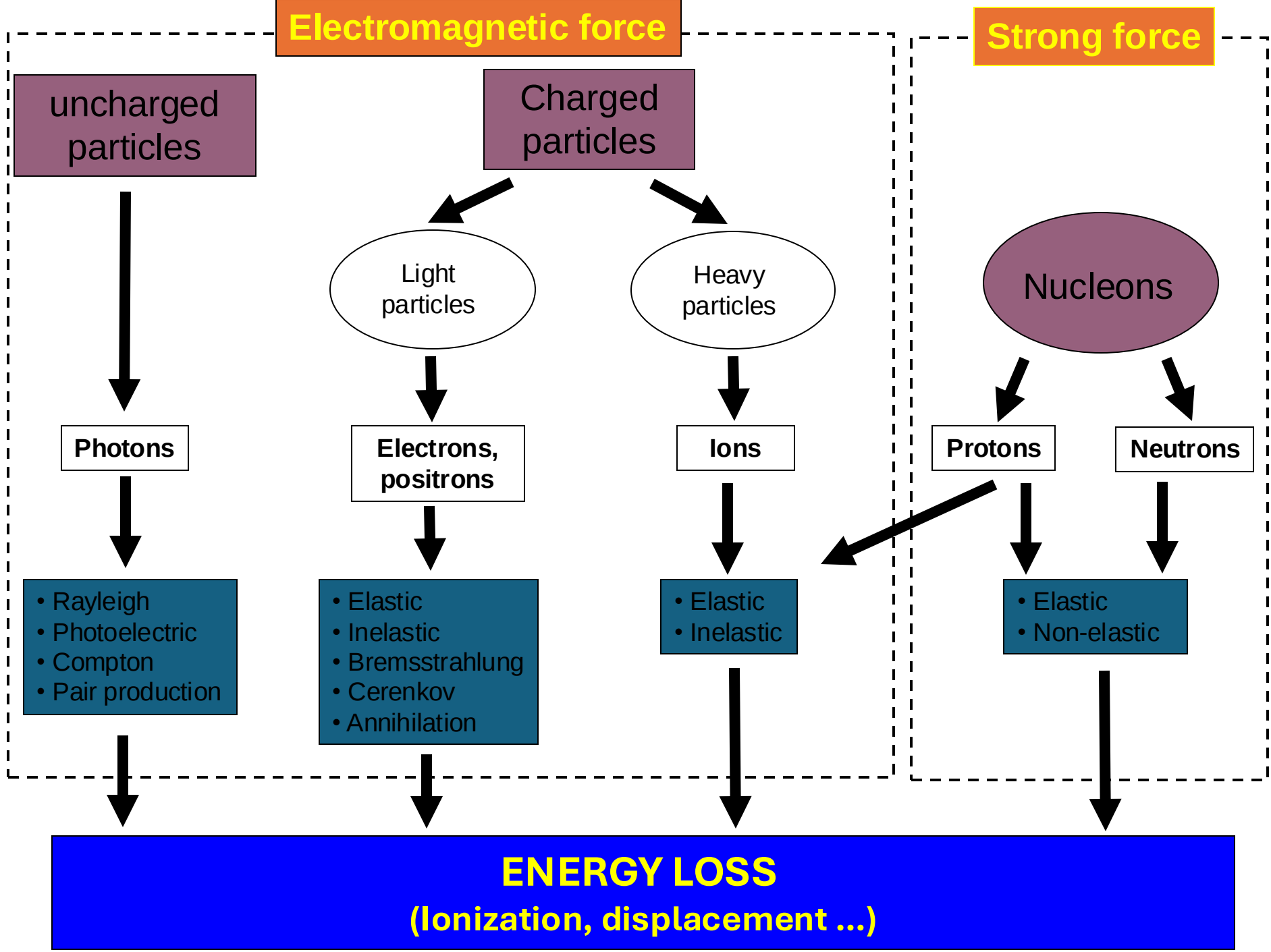
- Rayleigh
- Photoelectric
- Compton
- Pair production

- Elastic
- Inelastic
- Bremsstrahlung
- Cerenkov
- Annihilation

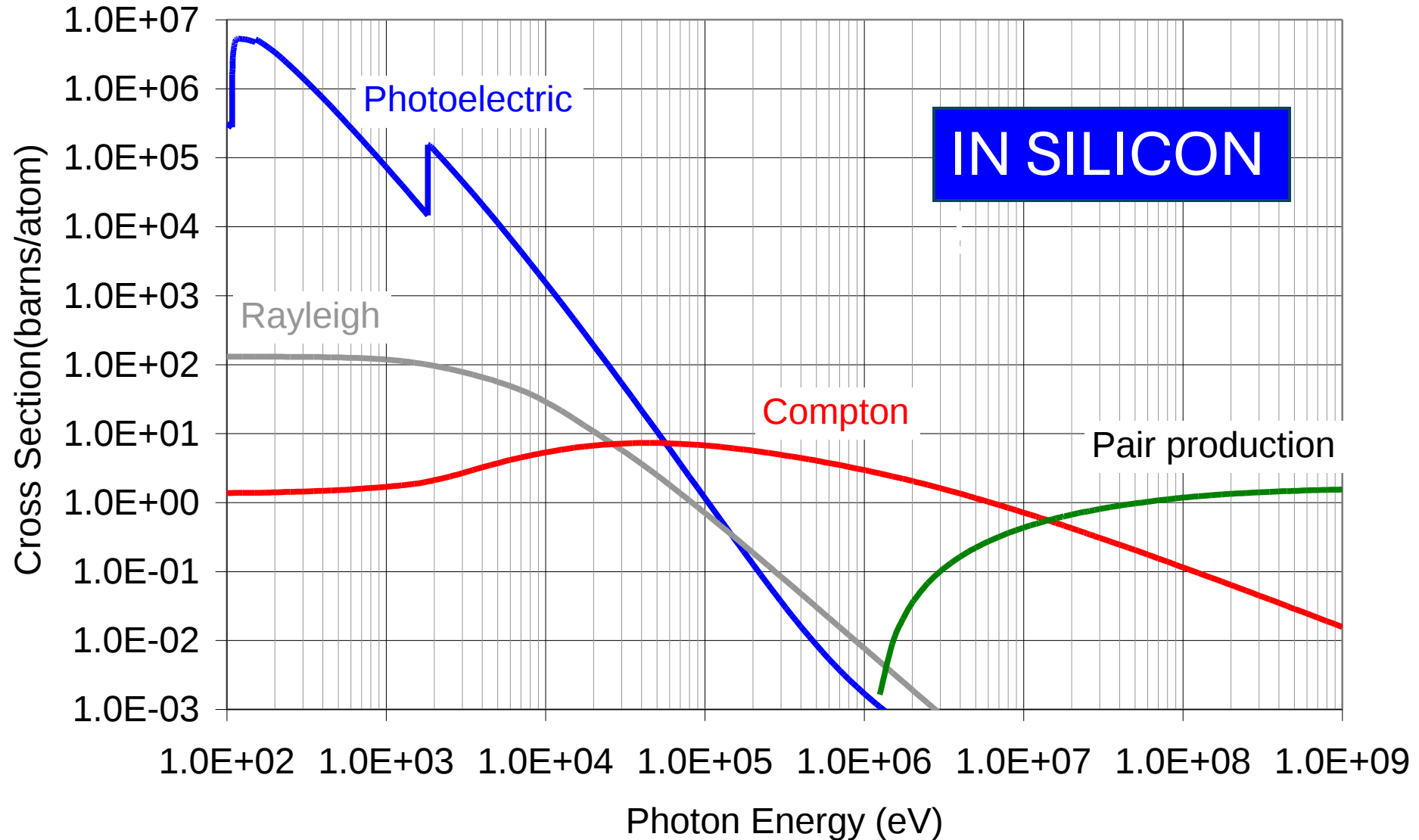
- Elastic
- Inelastic

- Elastic
- Non-elastic

ENERGY LOSS
(Ionization, displacement ...)



Photon-matter interaction



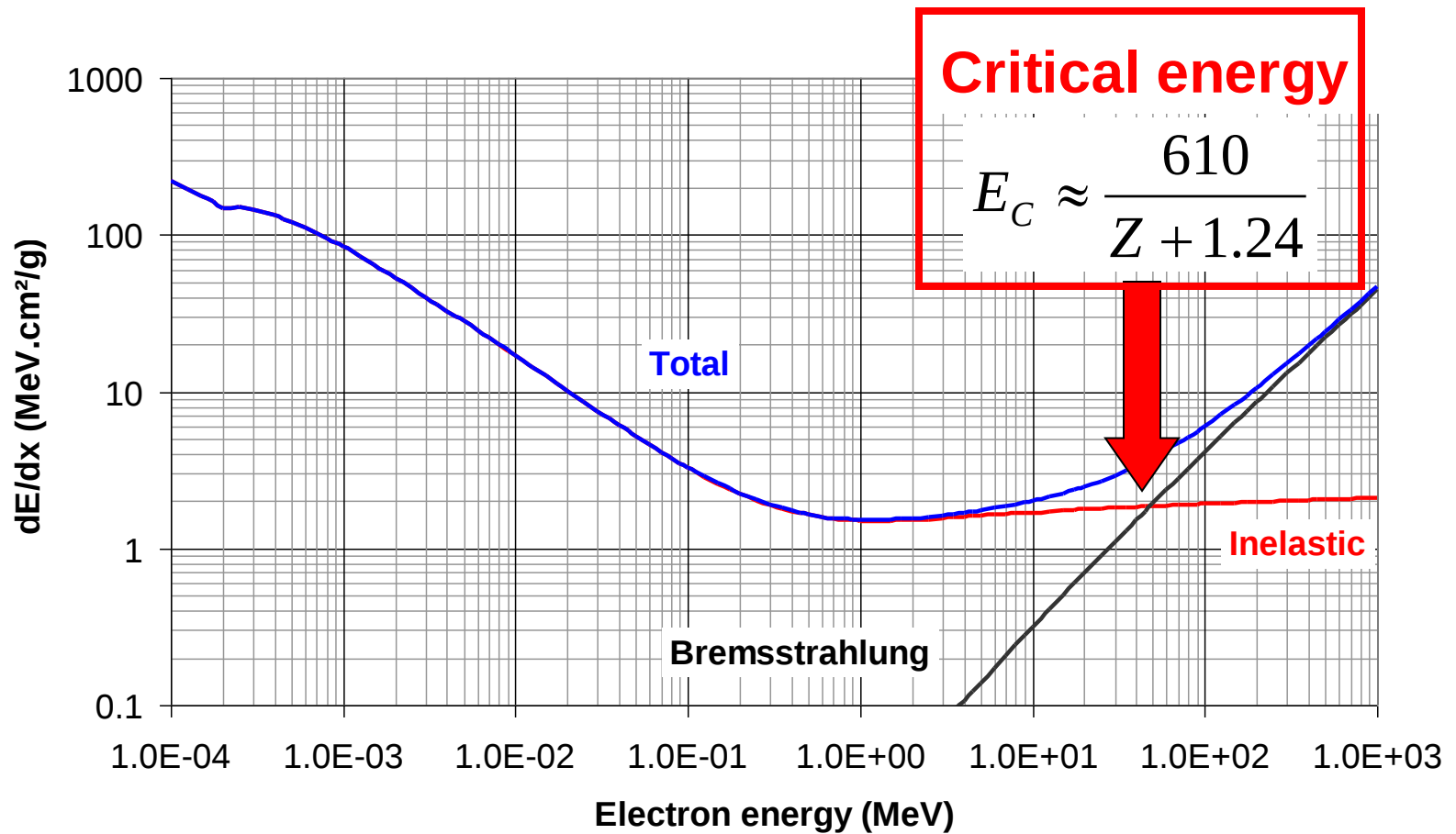
Photons interactions: Summary

Process	Summary	Cross Section
Rayleigh	• Photon is scattered	Negligible
Photoelectric	• Photon is absorbed • Electron is ejected	$\sigma_{pho} \propto Z^5$
Compton	• Photon is scattered • Electron is ejected	$\sigma_{Com} \propto Z$
Pair production	• Photon is absorbed • e^+e^- is created • Electron may be ejected	$\sigma_{prod} \propto Z^2$

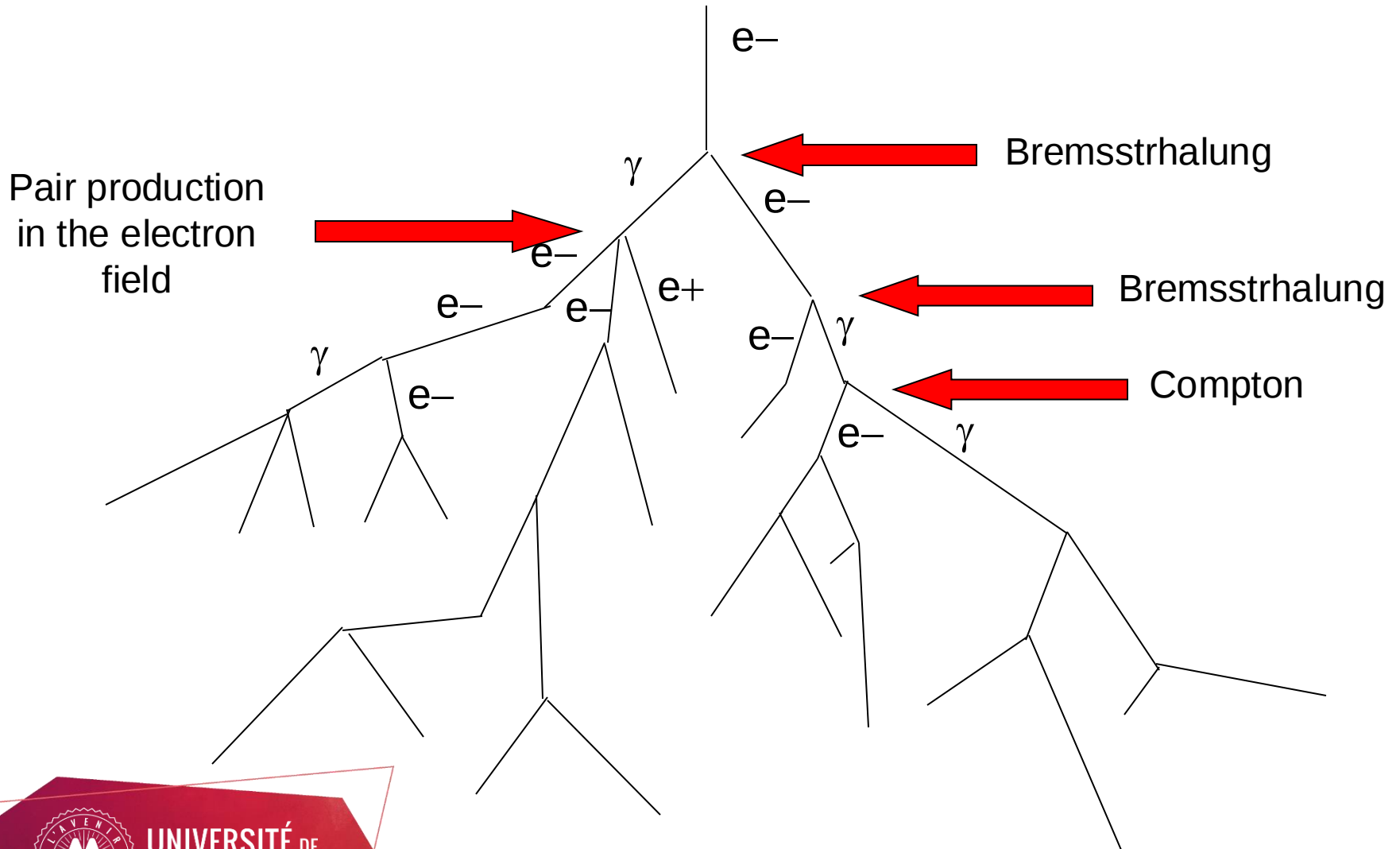
Electrons (and positrons) interactions

Process	Summary	Energy loss
Elastic	• Electron is scattered • No recoil	No energy loss
Inelastic	• Electronic excitation or ionization	Dominant
Bremsstrahlung	• Electron is deflected • Photon is emitted	Dominant
Cerenkov	• High velocity charged particle in insulator	Neglected
Annihilation	• 2 photons emission	Initial particle is absorbed

Electron total energy loss



Shower of particles



Ions Interactions

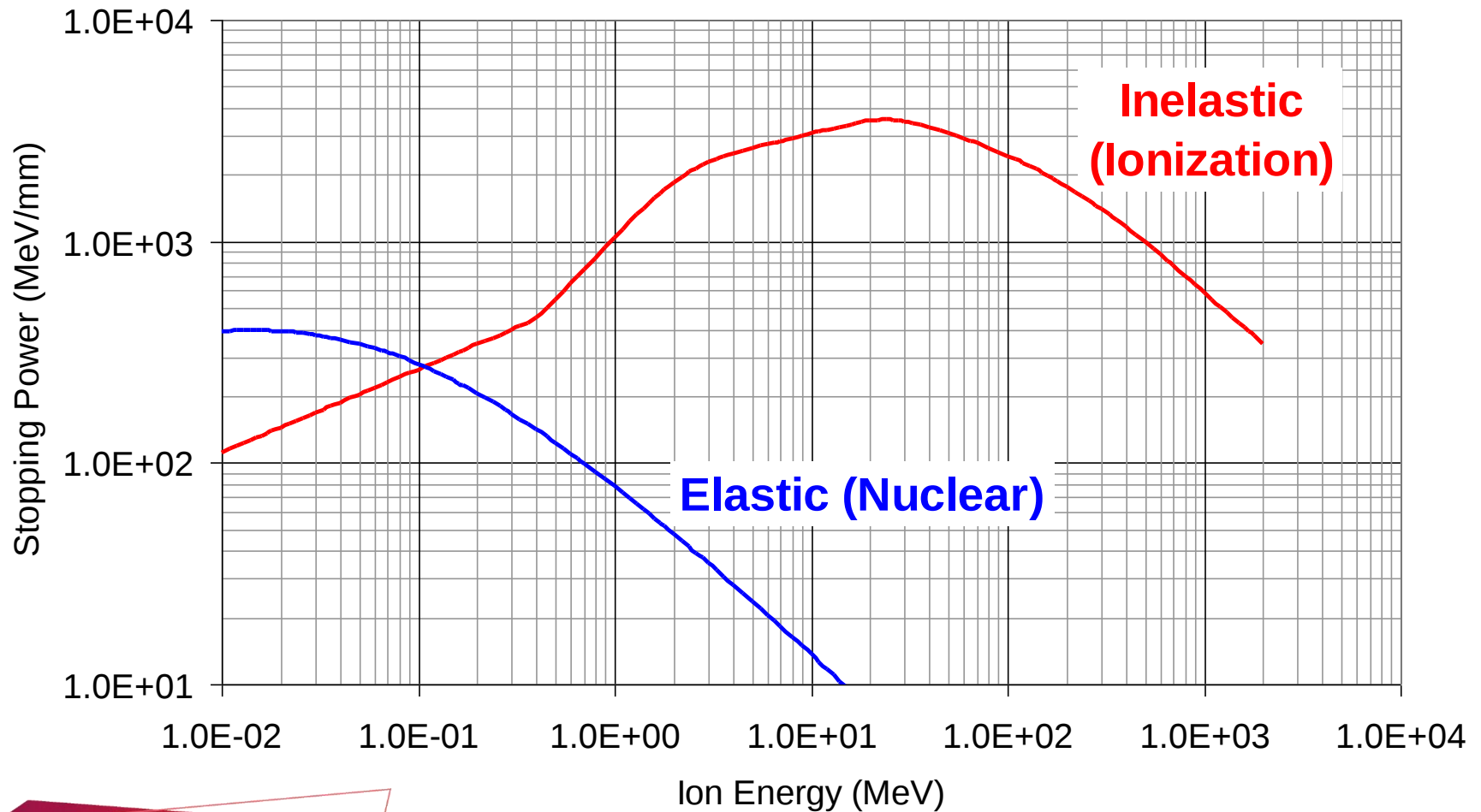
When an ion enters a target material there are 2 main effects that cause an energy loss:

- Elastic collisions with the nuclei of the target material
- Inelastic collisions with the electrons of the medium

- As for e^- and e^+ Bremsstrahlung emission is possible but due to the ion mass, the effect is negligible
- Generally, ions do not have relativistic speed : no Cerenkov effect



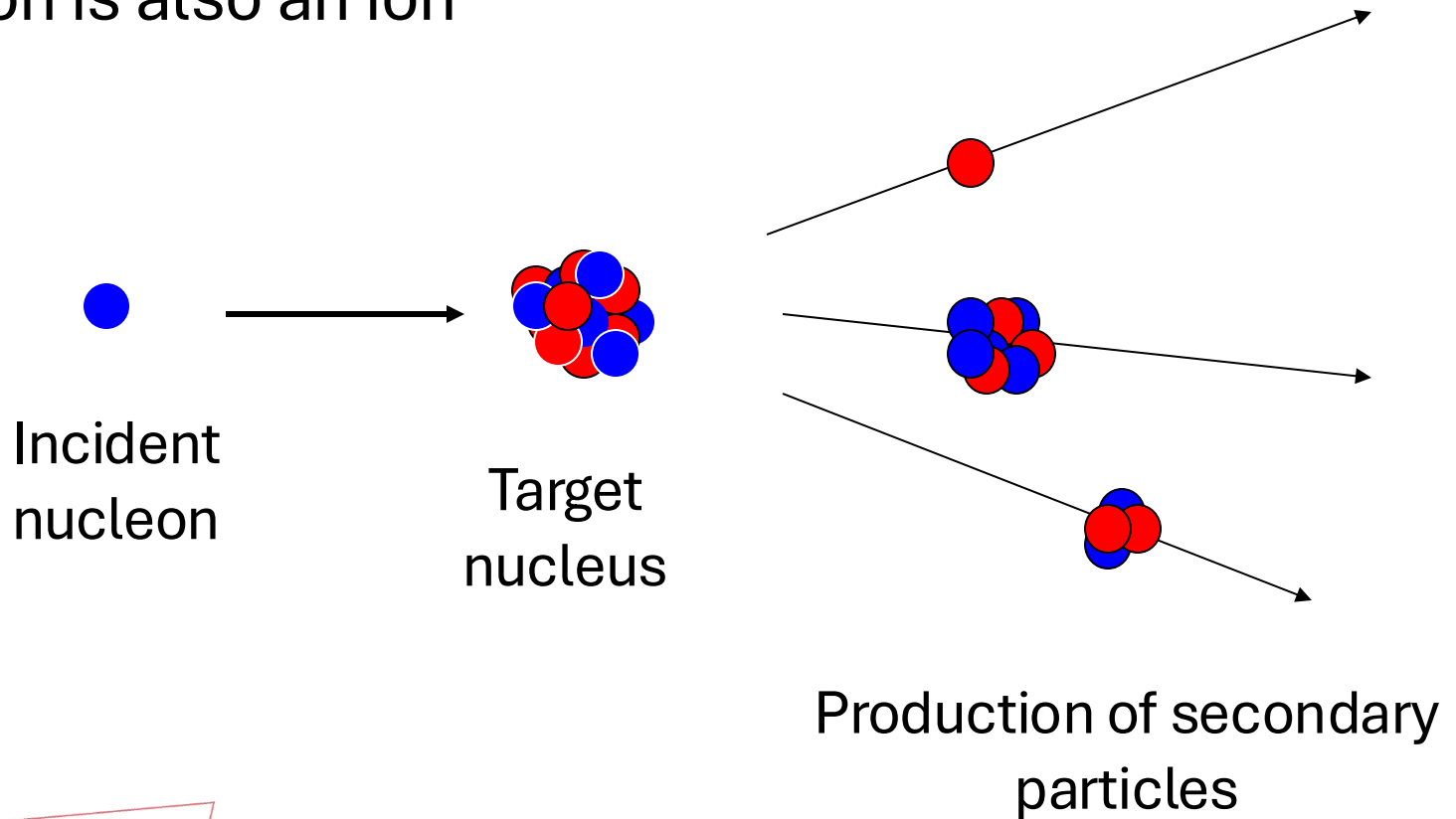
Stopping Power



Neutrons and protons induced nuclear reactions

Neutrons and protons interact by nuclear reactions

NB: proton is also an ion



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Particles	Processes	Secondary particles	Main effect for microelectronics
Photons	• Rayleigh • Photoelectric • Compton • Pair production	e^- , e^+ , photons	Ionization
Electrons, positrons	• Elastic • Inelastic • Bremsstrahlung • Cerenkov • Annihilation	e^- , e^+ , photons	Ionization
Ions	• Elastic • Inelastic	Ions, e^-	Ionization and Displacement
Nucleons	• Elastic • Nonelastic	Ions, photons, nucleons (pions ...)	Ionization and Displacement

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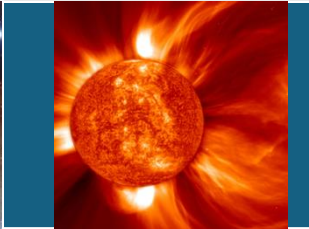
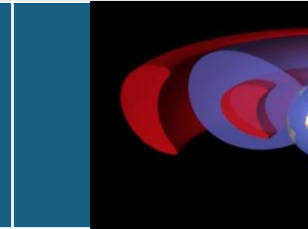
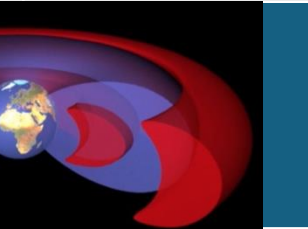


Conclusions

- Space and atmosphere are radiative environments
 - Space: ions, protons, electrons
 - Atmosphere: mainly neutrons
- There is a specific terminology for describing the properties of particles
- Each kind of particles interacts differently with matter and it is necessary to understand the fundamental on radiation-matter interaction



Conclusions

					
	Ions	Protons (solar flares)	Protons	Electrons	Neutrons
Single events	X	X	X		X
Ionising dose		X	X	X	
Displacement damage		X	X	x	

Radiations from space to ground level?

